

# New Jersey Semi-Conductor Products, Inc.

20 STERN AVE.  
SPRINGFIELD, NEW JERSEY 07081

**11SA**  
These silicon, planar, passivated, epitaxial transistors are intended to satisfy a wide range of general purpose applications at audio low and intermediate frequencies.

## Features:

- Excellent Gain Linearity over Wide Range of Collector Currents to 500mA and Beyond
- High Collector Current Ratings: 1000 mA.

- Integral Heat Sinks Available.
- Epoxy Encapsulation with Proved Reliability—excellent characteristic stability under environmental stresses, 85°C—85% RH.

Voltage and current values for PNP devices are negative; observe proper bias polarity

TO-92

## absolute maximum ratings: (25°C) (unless otherwise specified)

### Voltages

*Collector to Emitter	V <sub>CEO</sub>	60	Volts
*Emitter to Base	V <sub>EBO</sub>	5	Volts
*Collector to Base	V <sub>CBO</sub>	70	Volts
Collector to Emitter	V <sub>CEB</sub>	70	Volts

### Current

*Collector (Continuous)	I <sub>c</sub>	750	mA
Collector (Pulsed, 300 μsec. pulse width, ± 2½ duty cycle)	I <sub>cm</sub>	1000	mA

### Dissipation

Total Power (Free Air, T <sub>a</sub> = 25°C) <sup>(1)</sup>	P <sub>T</sub>	500	mW
Total Power with Heatsink (Free Air, T <sub>a</sub> = 25°C) <sup>(2)</sup>	P <sub>T</sub>	700	mW
Total Power with Heatsink (Case Temp., T <sub>c</sub> = 25°C) <sup>(3)</sup>	P <sub>T</sub>	1000	mW

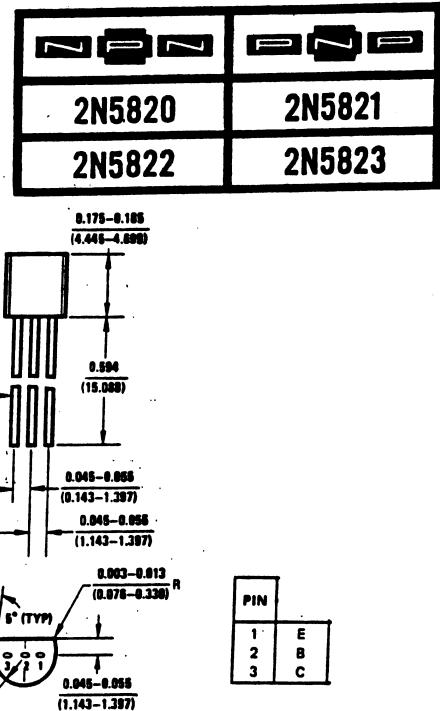
### Temperature

*Storage	T <sub>XTH</sub>	-65 to +150	°C
*Operating	T <sub>J</sub>	-65 to +135	°C
*Lead soldering (1/16" ± 1/32" from case for 10 sec. max.)	T <sub>L</sub>	+260	°C

<sup>(1)</sup>indicates JEDEC Registered values.

<sup>(2)</sup>Derate 4.55 mW/°C increase in ambient temperature above 25°C. <sup>(3)</sup>Derate 6.36 mW/°C increase in ambient temperature above 25°C. <sup>(4)</sup>Derate 9.09 mW/°C increase in case temperature above 25°C.

TELEPHONE: (973) 376-292  
(212) 227-600  
**Silicon** FAX: (973) 376-896  
**Transistors**



## electrical characteristics: (25°C) (unless otherwise specified)

NOTE: Characteristics apply to both heatsinked and non-heatsinked devices.

### STATIC CHARACTERISTICS

Collector Cutoff Current (V <sub>CE</sub> =25V)	I <sub>CEO</sub>	—	Min.	Max.	nA
(V <sub>CE</sub> =25V, T <sub>A</sub> =100°C)	I <sub>CEO</sub>	—	—	100	μA
Emitter Cutoff Current (V <sub>EE</sub> = 5V)	I <sub>EBO</sub>	—	—	15	μA
Forward Current Transfer Ratio *(I <sub>c</sub> = 2 mA, V <sub>CE</sub> = 2V)	h <sub>FE</sub>	—	10	μA	
2N5820, 2N5821	h <sub>FE</sub>	60	—	120	
2N5822, 2N5823	h <sub>FE</sub>	100	—	200	
*(I <sub>c</sub> = 500 mA, V <sub>CE</sub> = 2V)	h <sub>FE</sub>	20	—	—	
2N5820, 2N5821	h <sub>FE</sub>	25	—	—	
2N5822, 2N5823	h <sub>FE</sub>	—	—	—	
Collector-Emitter Breakdown Voltage *(I <sub>c</sub> = 10 mA)	V <sub>CEO(BD)</sub>	60	—	—	Volts
(I <sub>c</sub> = 10 μA)	V <sub>CEO(BD)</sub>	70	—	—	Volts
Emitter-Base Breakdown Voltage *(I <sub>e</sub> = 10 μA)	V <sub>EBO(BD)</sub>	5	—	—	Volts
Collector Saturation Voltage *(I <sub>c</sub> = 500 mA, I <sub>ce</sub> = 50 mA)	V <sub>CE(SAT)</sub>	—	0.75	—	Volts
Collector Saturation Voltage *(I <sub>c</sub> = 500 mA, I <sub>ce</sub> = 50 mA)	V <sub>CE(SAT)</sub>	—	1.2	—	Volts
Emitter Saturation Voltage *(I <sub>c</sub> = 500 mA, V <sub>CE</sub> = 2V)	V <sub>BE</sub>	.60	—	1.1	Volts

### DYNAMIC CHARACTERISTICS

Collector-Base Capacitance *(V <sub>CB</sub> = 10V, f = 1 MHz)	C <sub>cb</sub>	—	Min.	Max.	
Input Capacitance, Common Base (V <sub>BB</sub> = 0.5V, f = 1 MHz)	C <sub>ib</sub>	—	—	15	pF
Gain Bandwidth Product (I <sub>c</sub> = 50 mA, V <sub>CE</sub> = 2V, f = 20 MHz)	f <sub>T</sub>	—	—	55	MHz
2N5820, 2N5821	f <sub>T</sub>	100	—	—	MHz
2N5822, 2N5823	f <sub>T</sub>	120	—	—	MHz

<sup>(1)</sup>indicates JEDEC registered values.